



芯长恒科技

MPVA10N60

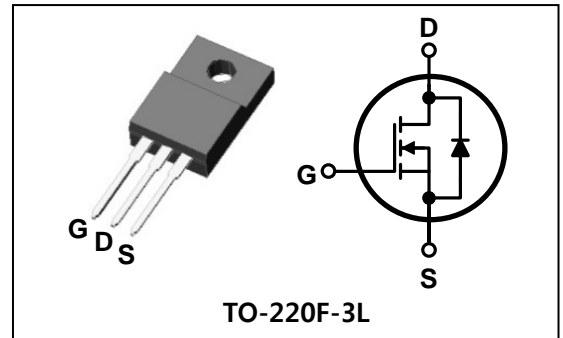
Power MOSFET

SWITCHING REGULATOR APPLICATIONS

Features

- High Voltage : $BV_{DSS}=600V(\text{Min.})$
- Low C_{rss} : $C_{rss}=18pF(\text{Typ.})$
- Low gate charge : $Qg=35nC(\text{Typ.})$
- Low $R_{DS(on)}$: $R_{DS(on)}=0.75\Omega(\text{Max.})$

PIN Connection

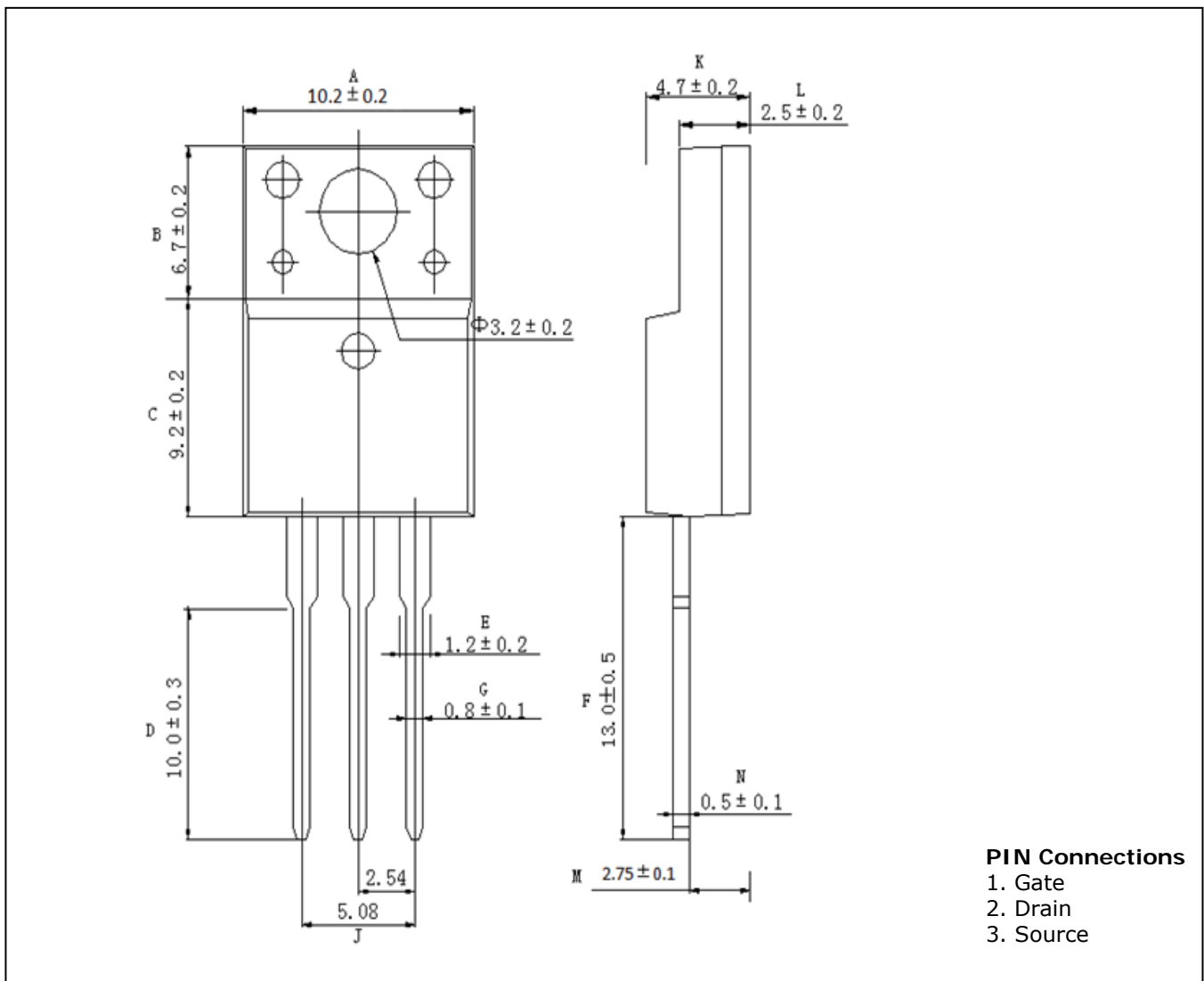


Ordering Information

Type NO.	Marking	Package Code
MPVA10N60	MPVA10N60	TO-220F-3L

Outline Dimensions

unit : mm



MPVA10N60

Power MOSFET

Absolute maximum ratings ($T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Rating	Unit	
Drain-source voltage	V_{DSS}	600	V	
Gate-source voltage	V_{GSS}	± 30	V	
Drain current (DC) *	I_D	$T_C=25^\circ\text{C}$	10	A
		$T_C=100^\circ\text{C}$	5.8	A
Drain current (Pulsed) *	I_{DM}	38	A	
Power dissipation	P_D	40	W	
Avalanche current (Single) ②	I_{AS}	10	A	
Single pulsed avalanche energy ②	E_{AS}	480	mJ	
Avalanche current (Repetitive) ①	I_{AR}	10	A	
Repetitive avalanche energy ①	E_{AR}	11.6	mJ	
Junction temperature	T_J	150	$^\circ\text{C}$	
Storage temperature range	T_{stg}	-55~150		

* Limited by maximum junction temperature

Characteristic		Symbol	Typ.	Max.	Unit
Thermal resistance	Junction-case	$R_{th(J-C)}$	-	3.1	$^\circ\text{C/W}$
	Junction-ambient	$R_{th(J-A)}$	-	62.5	

MPVA10N60

Power MOSFET

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit	
Drain-source breakdown voltage	BV_{DSS}	$I_D=250\mu\text{A}$, $V_{GS}=0\text{V}$	600	-	-	V	
Gate threshold voltage	$V_{GS(th)}$	$I_D=250\mu\text{A}$, $V_{DS}=V_{GS}$	2.0	-	4.0	V	
Drain-source cut-off current	I_{DSS}	$V_{DS}=600\text{V}$, $V_{GS}=0\text{V}$	-	-	1	μA	
Gate leakage current	I_{GSS}	$V_{DS}=0\text{V}$, $V_{GS}=\pm 30\text{V}$	-	-	± 100	nA	
Drain-source on-resistance ④	$R_{DS(on)}$	$V_{GS}=10\text{V}$, $I_D=5.0\text{A}$	-	0.60	0.75	Ω	
Forward transfer conductance ④	g_{fs}	$V_{DS}=10\text{V}$, $I_D=5.0\text{A}$	-	8.0	-	S	
Input capacitance	C_{iss}	$V_{GS}=0\text{V}$, $V_{DS}=25\text{V}$ $f=1\text{ MHz}$	-	2000	2350	pF	
Output capacitance	C_{oss}		-	160	215		
Reverse transfer capacitance	C_{rss}		-	18	-		
Turn-on delay time	$t_{d(on)}$	$V_{DD}=300\text{V}$, $I_D=10\text{A}$ $R_G=25\Omega$	-	23	-	ns	
Rise time	t_r		-	69	-		
Turn-off delay time	$t_{d(off)}$		③④	-	144		-
Fall time	t_f		-	77	-		
Total gate charge	Q_g	$V_{DS}=480\text{V}$, $V_{GS}=10\text{V}$ $I_D=10\text{A}$	-	35	57	nC	
Gate-source charge	Q_{gs}		③④	-	9		-
Gate-drain charge	Q_{gd}		-	10	-		

Source-Drain Diode Ratings and Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Source current (DC)	I_S	Integral reverse diode in the MOSFET	-	-	10	A
Source current (Pulsed) ①	I_{SM}		-	-	40	
Forward voltage ④	V_{SD}	$V_{GS}=0\text{V}$, $I_S=10\text{A}$	-	-	1.4	V
Reverse recovery time	t_{rr}	$I_S=10\text{A}$, $V_{GS}=0\text{V}$ $dI_F/dt=100\text{A}/\mu\text{s}$	-	470	-	ns
Reverse recovery charge	Q_{rr}		-	6	-	μC

Note ;

- ① Repetitive rating : Pulse width limited by maximum junction temperature
- ② $L=10\text{mH}$, $I_{AS}=9.5\text{A}$, $V_{DD}=50\text{V}$, $R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$
- ③ Pulse Test : Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$
- ④ Essentially independent of operating temperature

Electrical Characteristic Curves

Fig. 1 $I_D - V_{DS}$

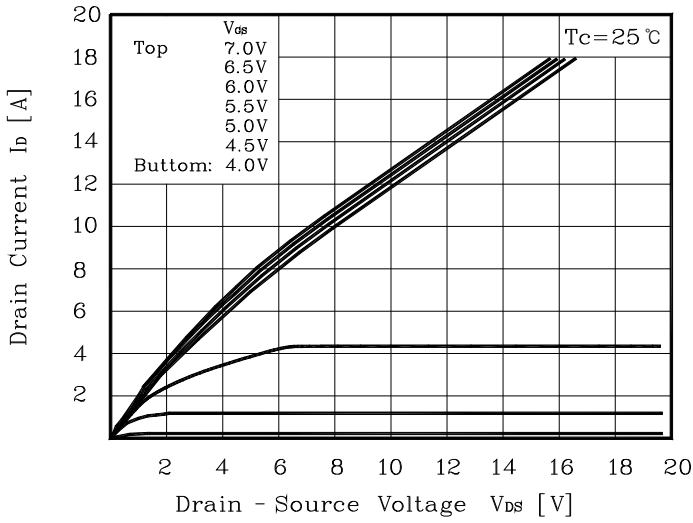


Fig. 2 $I_D - V_{GS}$

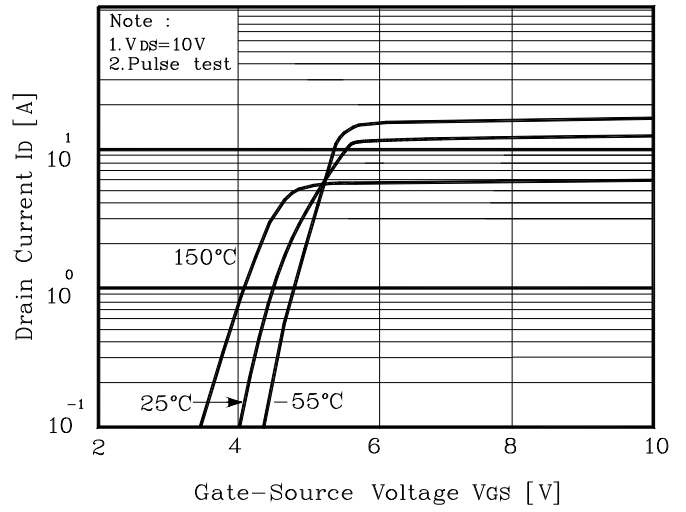


Fig. 3 $R_{DS(on)} - I_D$

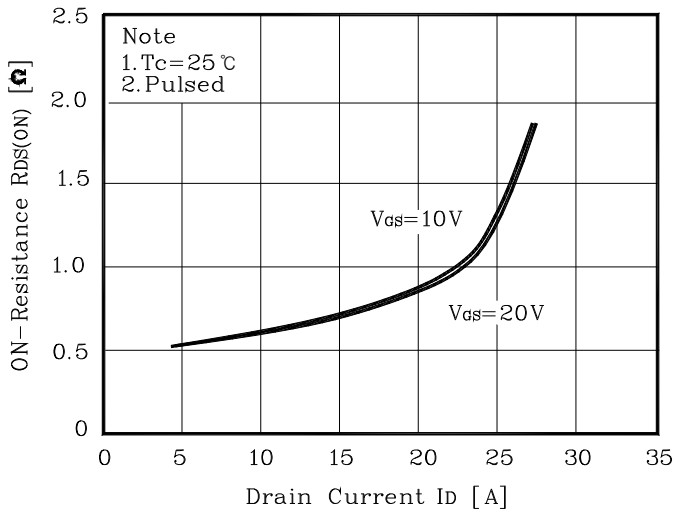


Fig. 4 $I_S - V_{SD}$

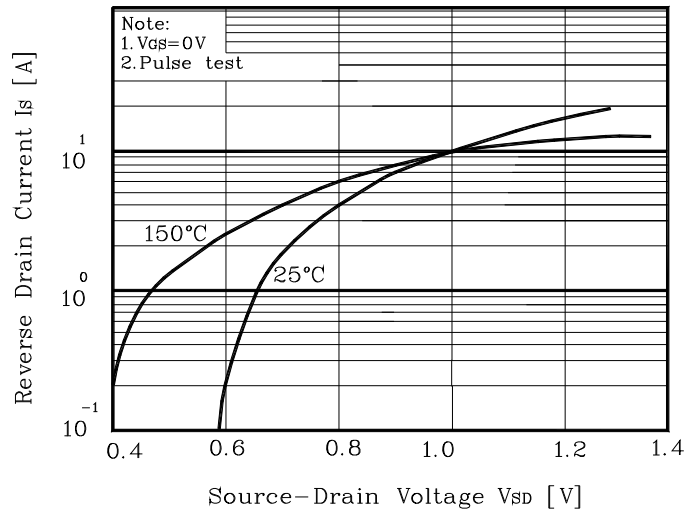


Fig. 5 Capacitance - V_{DS}

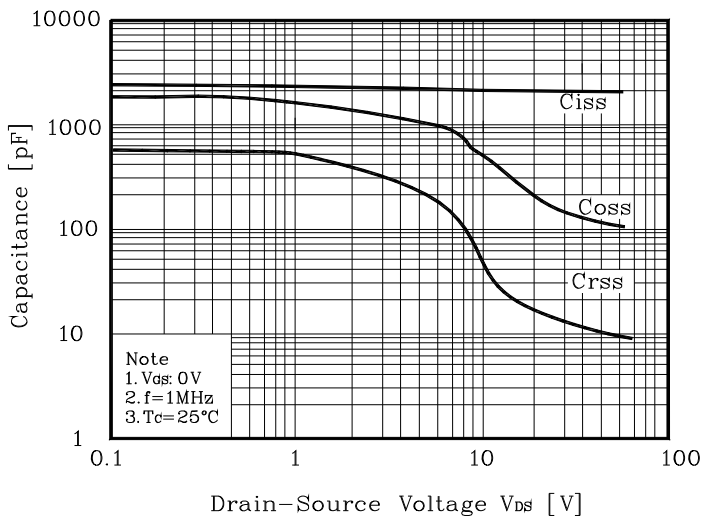
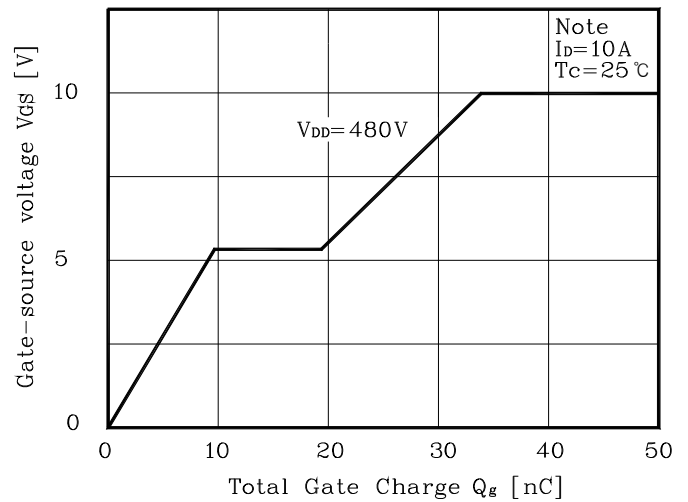


Fig. 6 $V_{GS} - Q_g$



Electrical Characteristic Curves

Fig. 7 $V_{DSS} - T_J$

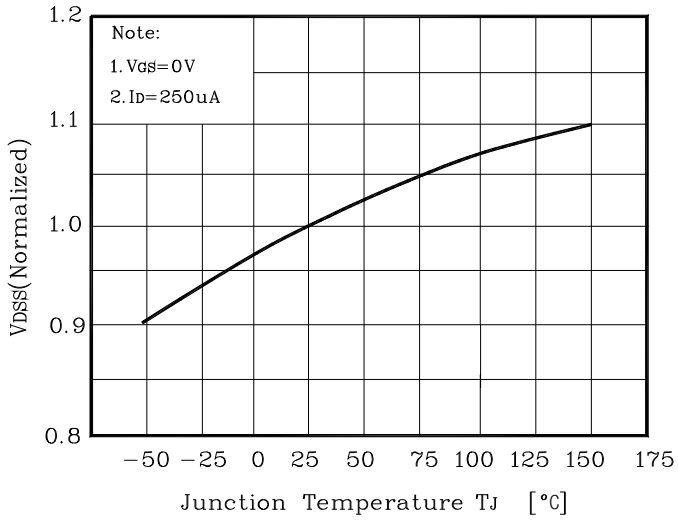


Fig.8 $R_{DS(on)} - T_J$

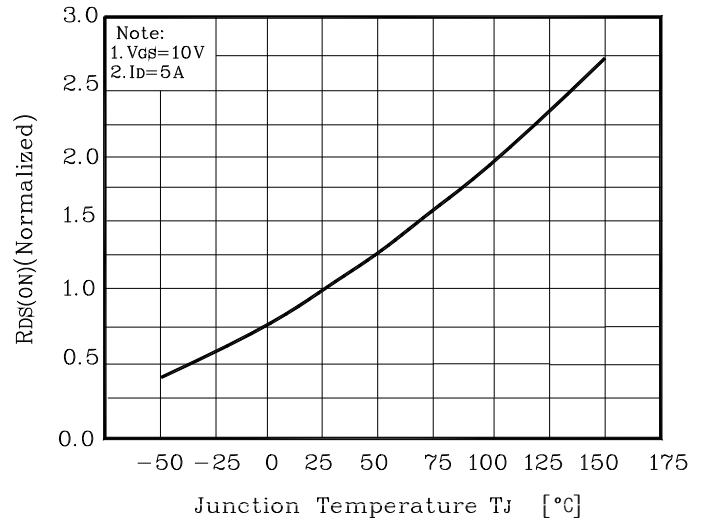


Fig. 9 $I_D - T_C$

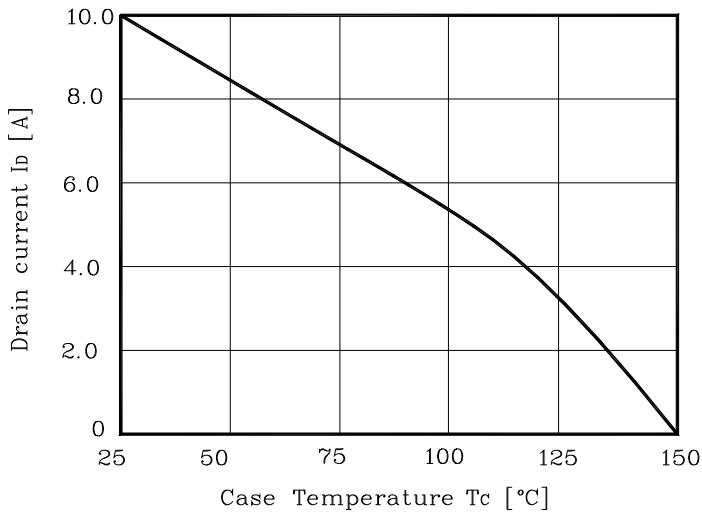


Fig. 10 Safe Operating Area

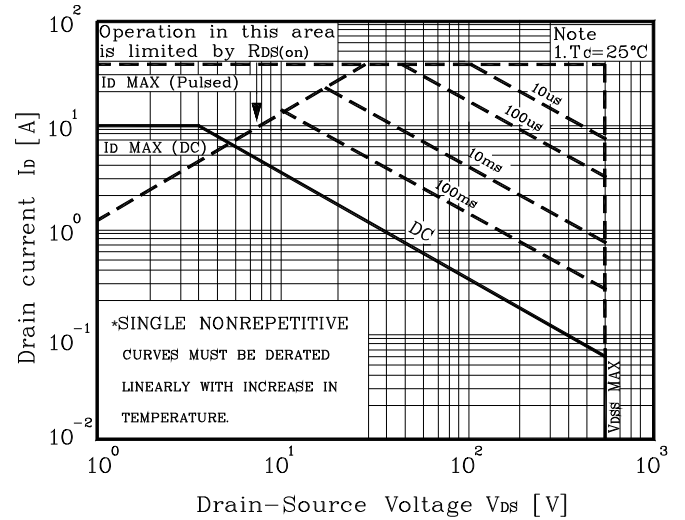


Fig. 11 Gate Charge Test Circuit & Waveform

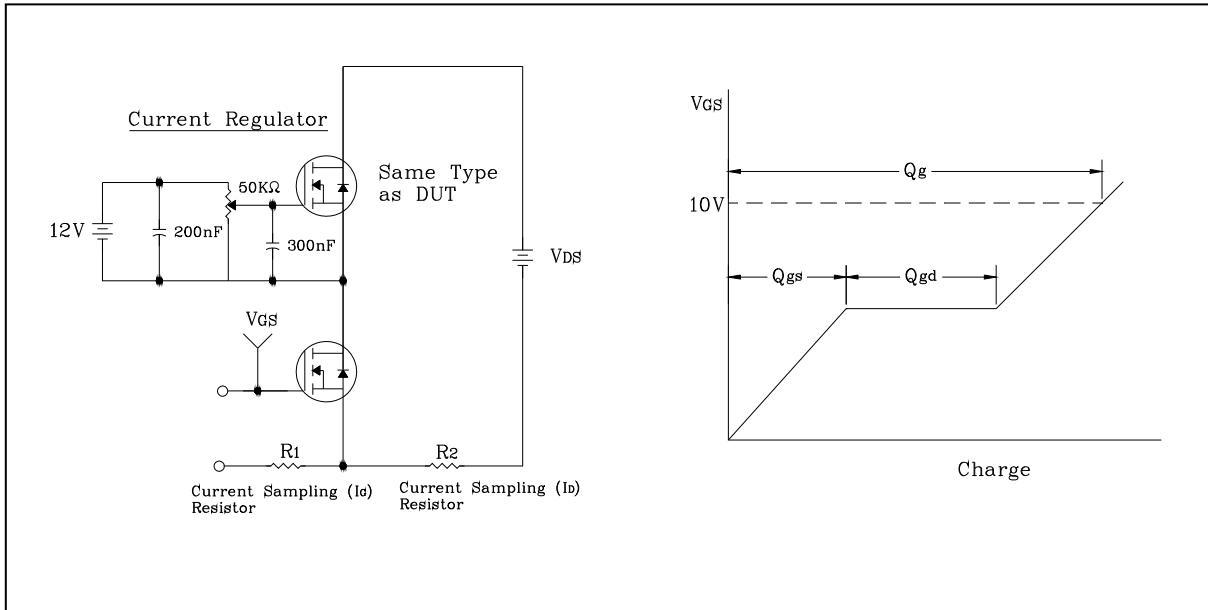


Fig. 12 Resistive Switching Test Circuit & Waveform

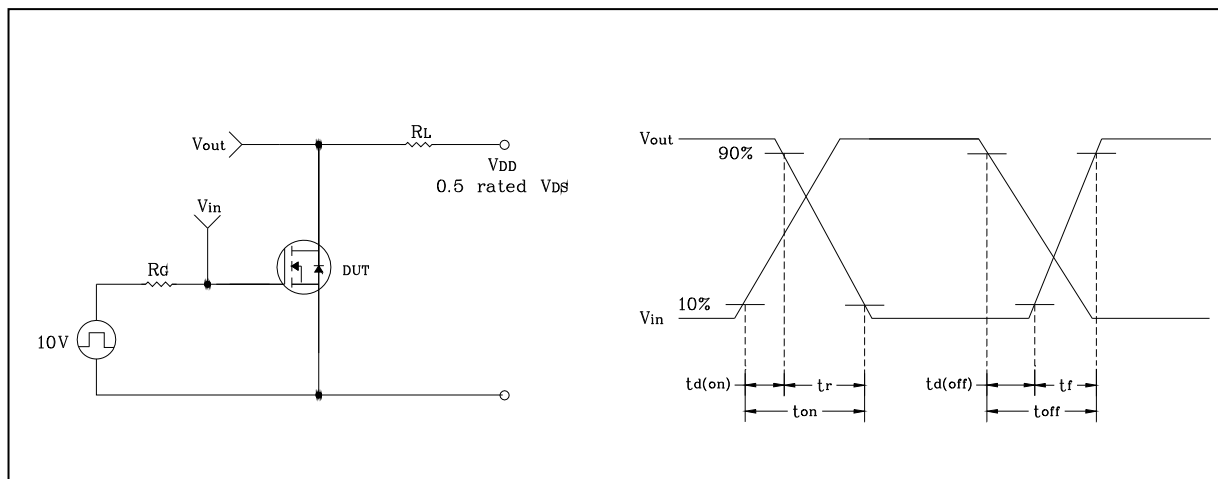


Fig. 13 EAS Test Circuit & Waveform

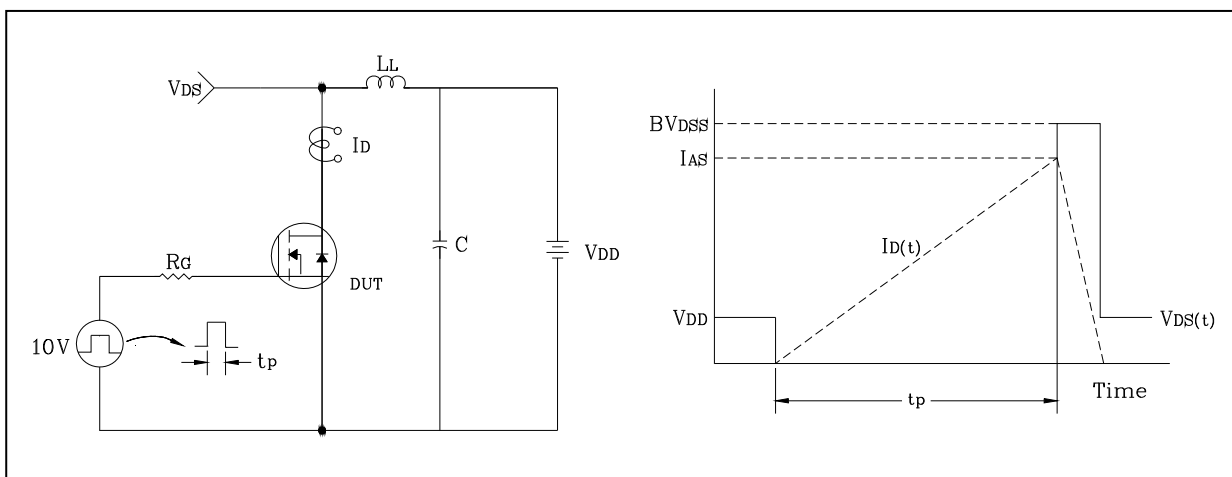


Fig. 14 Diode Reverse Recovery Time Test Circuit & Waveform

